
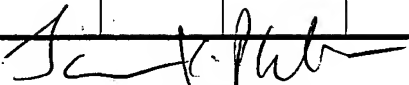
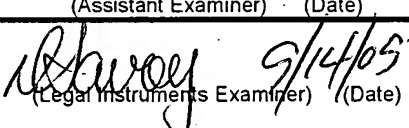


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/016,438	LAI ET AL.	
	Examiner	Art Unit	
	Jacob Meek	2637	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
375		222			375	355			
INTERNATIONAL CLASSIFICATION									
H	0	4	B	1/38					
H	0	4	L	7/00					
				/					
				/					
				/					
Jacob Meek 9/8/05 (Assistant Examiner) (Date)					 JAY K. PATEL SUPERVISORY PATENT EXAMINER 9/13/05 (Primary Examiner) (Date)			Total Claims Allowed: 19	
 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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